# DATA SHEET



# MOS FIELD EFFECT TRANSISTOR NP83P04PDG

# SWITCHING P-CHANNEL POWER MOSFET

## DESCRIPTION

The NP83P04PDG is P-channel MOS Field Effect Transistor designed for high current switching applications.

#### <R> ORDERING INFORMATION

PART NUMBER	LEAD PLATING	PACKING	PACKAGE	
NP83P04PDG-E1-AY Note		T 000 /		
NP83P04PDG-E2-AY Note	Pure Sn (Tin)	Tape 800 p/reel	TO-263 (MP-25ZP)	

Note Pb-free (This product does not contain Pb in external electrode.)

#### FEATURES

• Super low on-state resistance

 $R_{DS(on)1} = 5.3 \text{ m}\Omega \text{ MAX.} (V_{GS} = -10 \text{ V}, \text{ ID} = -41.5 \text{ A})$ 

 $R_{DS(on)2} = 8.0 \text{ m}\Omega \text{ MAX.}$  (VGs = -4.5 V, ID = -41.5 A)

• High current rating: ID(DC) = ∓83 A

#### ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (VGs = 0 V)	VDSS	-40	V
Gate to Source Voltage (VDs = 0 V)	Vgss	∓20	V
Drain Current (DC) (Tc = 25°C)	D(DC)	∓83	А
Drain Current (pulse) <sup>Note1</sup>	D(pulse)	∓249	А
Total Power Dissipation (Tc = 25°C)	<b>Ρ</b> τ1	150	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Pt2	1.8	W
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C
Single Avalanche Current Note2	las	56	А
Single Avalanche Energy Note2	Eas	315	mJ

**Notes 1.** PW  $\leq$  10  $\mu$ s, Duty Cycle  $\leq$  1%

**2.** Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = -30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> =  $-20 \rightarrow 0$  V

#### THERMAL RESISTANCE

Channel to Case Thermal Resistance	Rth(ch-C)	1.0	°C/W
Channel to Ambient Thermal Resistance	Rth(ch-A)	83.3	°C/W

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Document No. D18690EJ3V0DS00 (3rd edition) Date Published May 2007 NS CP(K) Printed in Japan © NEC Electronics Corporation 2007

The mark <R> shows major revised points.

The revised points can be easily searched by copying an "<R>" in the PDF file and specifying it in the "Find what:" field.



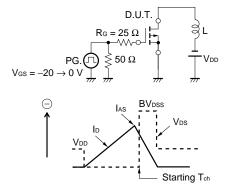
(TO-263)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = -40 V, V <sub>GS</sub> = 0 V			-10	μA
Gate Leakage Current	lgss	V <sub>GS</sub> = ∓20 V, V <sub>DS</sub> = 0 V			<b>∓100</b>	nA
Gate to Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = −10 V, I <sub>D</sub> = −1 mA	-1.0	-1.6	-2.5	V
Forward Transfer Admittance Note	y <sub>fs</sub>	Vds = -10 V, Id = -41.5 A	30	60		S
Drain to Source On-state Resistance Note	RDS(on)1	Vgs = -10 V, Id = -41.5 A		4.1	5.3	mΩ
	RDS(on)2	V <sub>GS</sub> = −4.5 V, I <sub>D</sub> = −41.5 A		5.1	8.0	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = -10 V,		9820		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V,		1500		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		850		pF
Turn-on Delay Time	td(on)	V <sub>DD</sub> = -20 V, I <sub>D</sub> = -41.5 A,		35		ns
Rise Time	tr	V <sub>GS</sub> = -10 V,		21		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 0 Ω		245		ns
Fall Time	tr			120		ns
Total Gate Charge	QG	$V_{DD} = -32 V,$		200		nC
Gate to Source Charge	QGS	V <sub>GS</sub> = -10 V,		25		nC
Gate to Drain Charge	Qgd	I⊳ = –83 A		53		nC
Body Diode Forward Voltage Note	V <sub>F(S-D)</sub>	IF = -83 A, VGS = 0 V		0.93	1.5	V
Reverse Recovery Time	trr	IF = -83 A, VGS = 0 V,		57		ns
Reverse Recovery Charge	Qrr	di/dt = −100 A/µs		92		nC

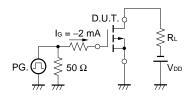
**Note** Pulsed test PW  $\leq$  350  $\mu$ s, Duty Cycle  $\leq$  2%

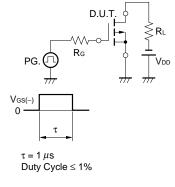
#### TEST CIRCUIT 1 AVALANCHE CAPABILITY

#### **TEST CIRCUIT 2 SWITCHING TIME**



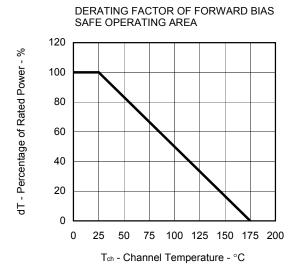
# TEST CIRCUIT 3 GATE CHARGE



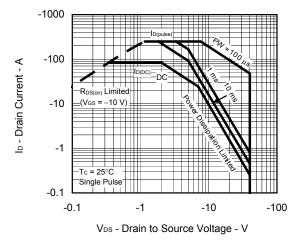


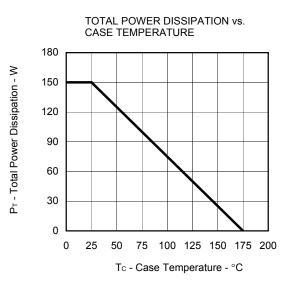
[	Vgs(-)		
V <sub>GS</sub> Wave Form	0 <u>10%</u>	Vgs	90%
Vos Wave Form	VDS(-) VDS 0 td(on) tc	tr td(off)	+90% tr toff

# TYPICAL CHARACTERISTICS (TA = 25°C)

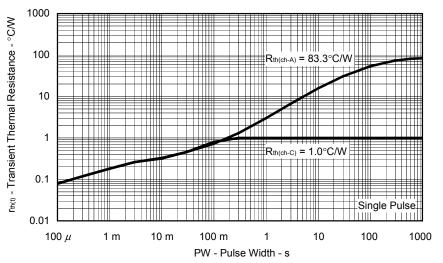




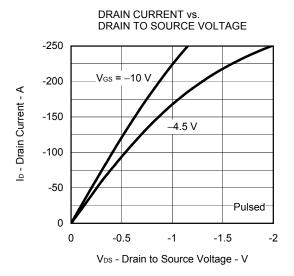




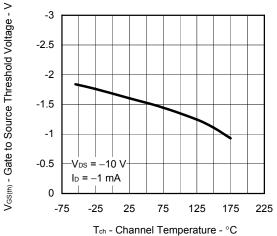
#### TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



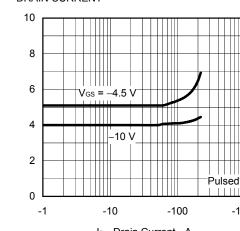
Data Sheet D18690EJ3V0DS



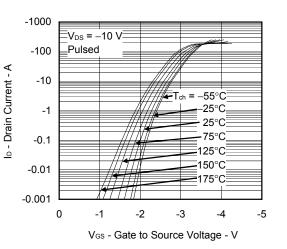
GATE TO SOURCE THRESHOLD VOLTAGE vs. CHANNEL TEMPERATURE



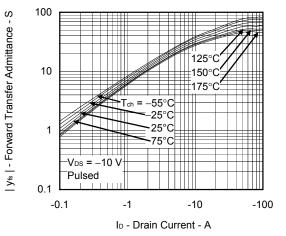
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



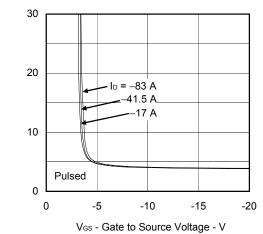
ID - Drain Current - A



FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE

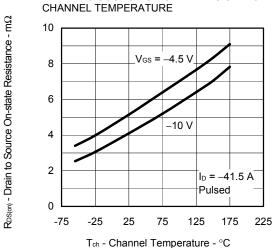


FORWARD TRANSFER CHARACTERISTICS

-1000

 $R_{DS(on)}$  - Drain to Source On-state Resistance -  $m\Omega$ 

 $R_{DS(on)}$  - Drain to Source On-state Resistance -  $m\Omega$ 



SWITCHING CHARACTERISTICS

-10

-100

td(off)

td(on)

tr

-1

V<sub>DD</sub> = -20 V V<sub>GS</sub> = -10 V R<sub>G</sub> = 0 Ω

1000

100

10

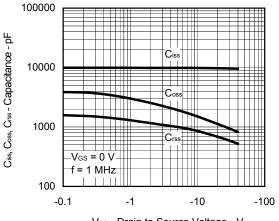
1

-0.1

td(on), tr, td(off), tr - Switching Time - ns

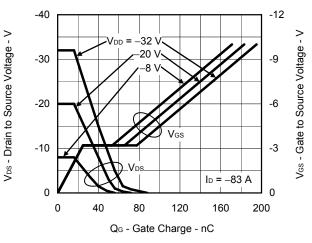
DRAIN TO SOURCE ON-STATE RESISTANCE vs.

CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE

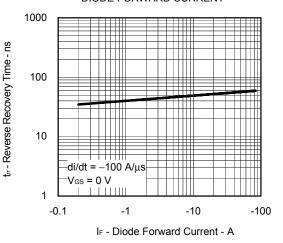


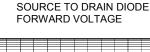
V<sub>DS</sub> - Drain to Source Voltage - V

DYNAMIC INPUT/OUTPUT CHARACTERISTICS

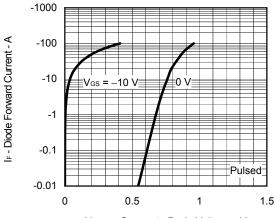


REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT





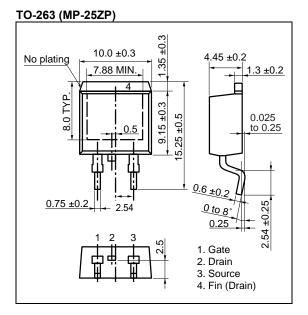
ID - Drain Current - A



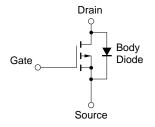
V<sub>F(S-D)</sub> - Source to Drain Voltage - V

Data Sheet D18690EJ3V0DS

## PACKAGE DRAWING (Unit: mm)



## EQUIVALENT CIRCUIT



**Remark** Strong electric field, when exposed to this device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it once, when it has occurred.

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